

# Development of High Efficiency Segmented Thermoelectric Couples for Space Applications

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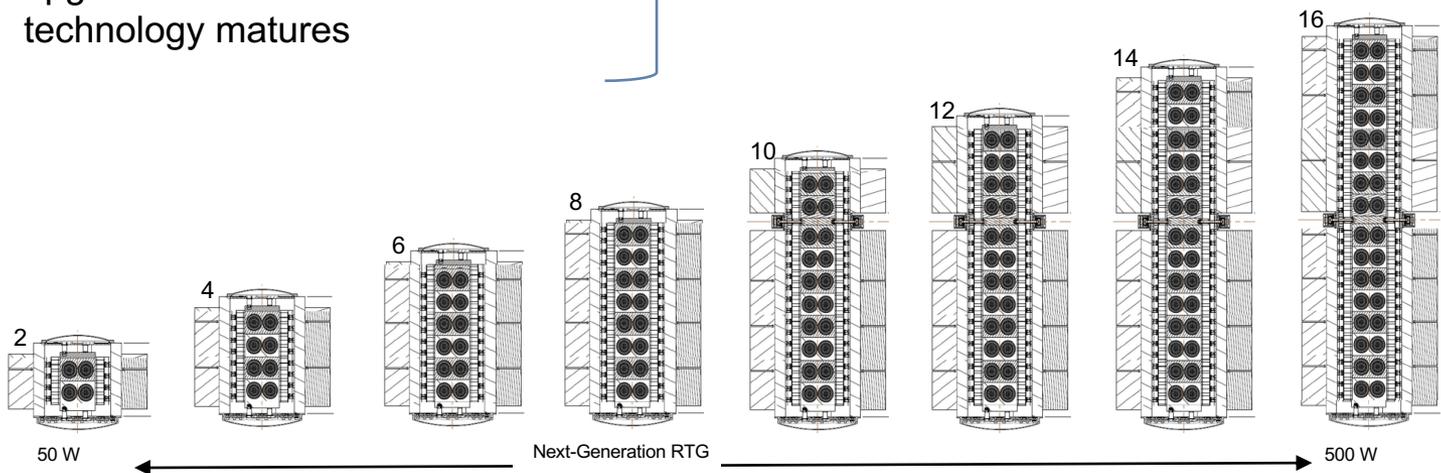
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# Next Generation RTG Study Recommendations

- **NG-RTG:**
  - Vacuum Only
  - Modular
- **Variants: 2, 4, 6, 8, 10, 12, 14, and 16 GPHS variants**
  - 16 GPHSs (largest RTG variant)
  - $P_{BOM} = 400-500 W_e$  (largest RTG variant)
  - Mass goal of  $< 60 kg$  (largest RTG variant)
  - Degradation rate  $< 1.9 \%$
  - System to be designed to be upgraded with new TCs as technology matures

Three (3) couple configurations have been selected, with conversion efficiencies ranging from  $e=13\%$  to  $e=16.4\%$

Conversion efficiencies for heritage systems is  $e\sim 7\%$



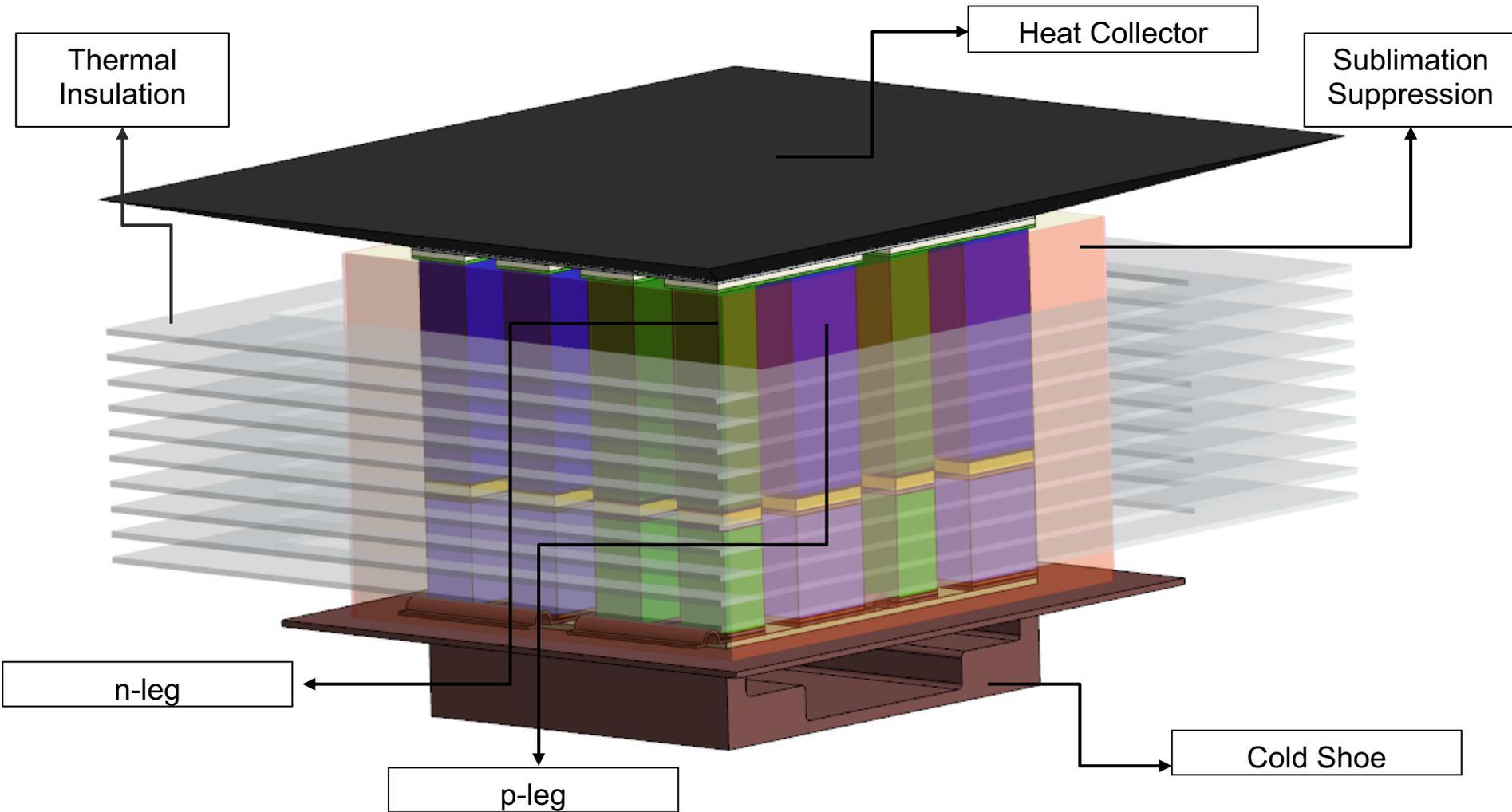
# NG-RTG Couple Configurations

Configuration #	n		p		Current (study*) Predicted Materials-based Couple Efficiency (%)	Current (study*) Estimated BOL RTG Efficiency (%)	Current (study*) Estimated BOL RTG Power (W)
	Low	High	Low	High	16-GPHS, 250W per GPHS		
1	1-2-2 Zintl	La <sub>3-x</sub> Te <sub>4</sub> /composite	9-4-9 Zintl	14-1-11 Zintl	14.7 (16.4*)	12.8 (14.3*)	513 (572*)
3	SKD	La <sub>3-x</sub> Te <sub>4</sub> /composite	SKD	14-1-11 Zintl	13.9 (15.6*)	12.1 (13.6*)	485 (544*)
14		La <sub>3-x</sub> Te <sub>4</sub> /composite		14-1-11 Zintl	11.1 (13.0*)	9.7 (11.3*)	387 (452*)

- Efficiency calculated during Next Gen RTG study used higher ZT La<sub>3-x</sub>Te<sub>4</sub>/composite material produced by small batch synthesis (15 gr).
  - Current Project baseline (April 2018) produced by large batch synthesis process (100 g)
  - **Process optimization to reproduce these original results is in progress**
- Couple efficiency based on couple operating T<sub>hot junction</sub> = 1273 K, T<sub>inter-segment</sub> = 773 K and T<sub>cold junction</sub> = 450K
  - **Lower temperature segments, such as SKDs, would operate no higher than 773 K (500 C)**
  - **Most of hot side interface degradation risk would be for 14-1-11 Zintl and La<sub>3-x</sub>Te<sub>4</sub>/composite**
- Estimated BOL system-level efficiency based on heritage RTG performance (derating factor)
  - GPHS-RTG: couple (7.5%) ; system (6.5%)
  - MMRTG: couple (7.1%); system (6,3%)

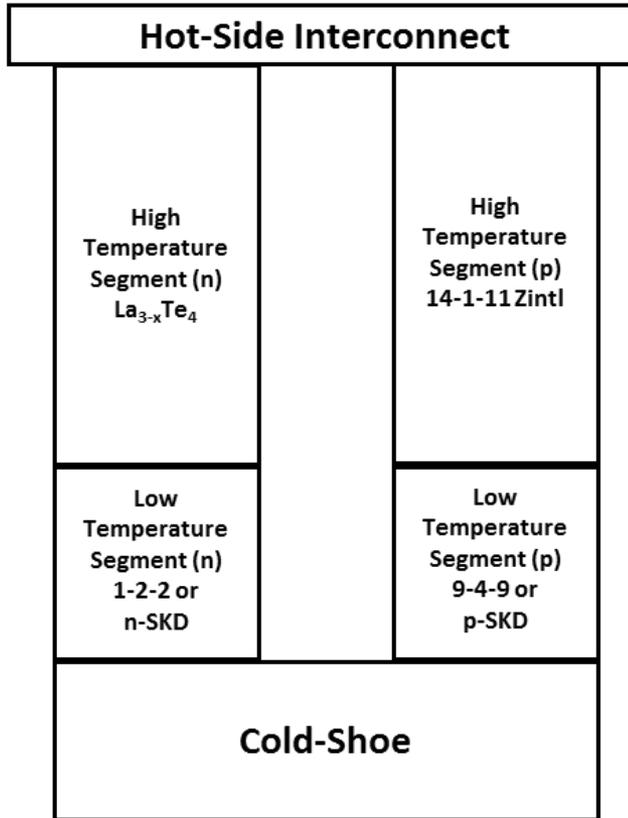
# NG-RTG Multicouple

- $\geq 11\%$  system conversion efficiency ( $\geq 60\%$  improvement over MMRTG at BOL)
- $\geq 6-8.5$  We/kg specific power (2-3 x improvement over MMRTG)
- 1.9%/year or lower power degradation average over 17 years (including isotope decay)



# Managing Technology Development Risk

## Ex. All Zintl Segmented Couple



$T_{\text{Hot Junction}}$

$T_{\text{Segmentation}}$

$T_{\text{Cold Junction}}$

$T_{\text{HOT}}$ (K)	$T_{\text{COLD}}$ (K)	Efficiency* (%)
1273	450	15.8
<b>1223</b>	450	15.2
1173	450	14.5
1123	450	13.7
1073	450	13.0
<b>1023</b>	450	12.2
973	450	11.4

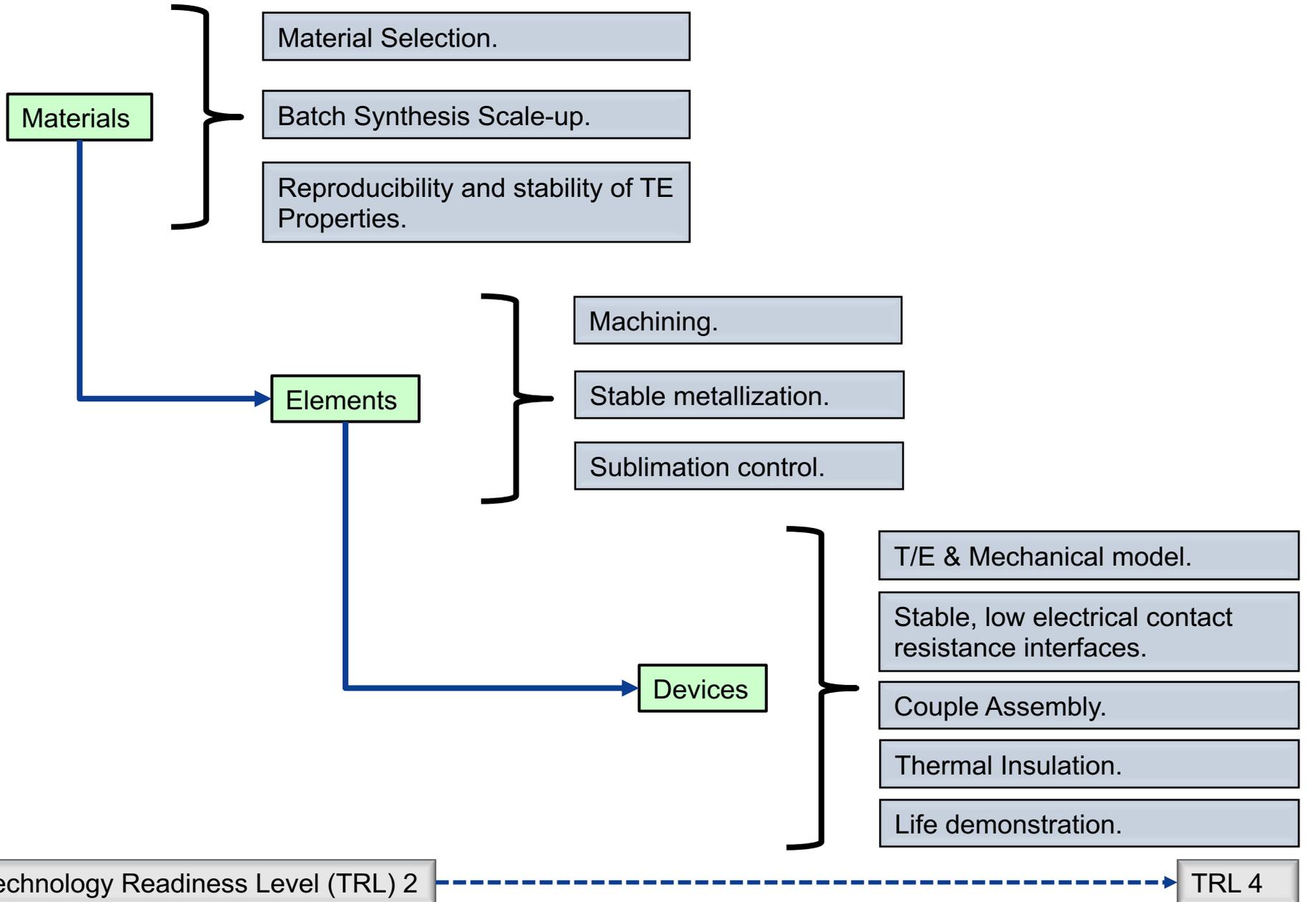
← 500W target

← 400W target

*\*Preliminary prediction – will be updated periodically*

... We can reduce hot-junction temperature and subsequently minimize degradation rate

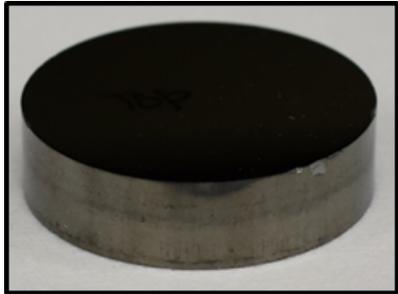
# Overlap Between Tasks Ensures Concurrent Development



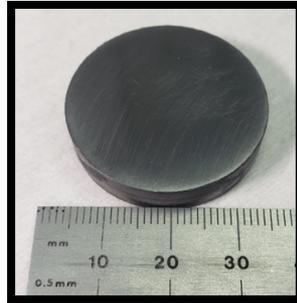
# Materials Highlight

Successfully sintered 32mm diameter pucks of 14-1-11 Zintl, LaTe, LaTe Composite, 1-2-2 Zintl and 9-4-9 Zintl.

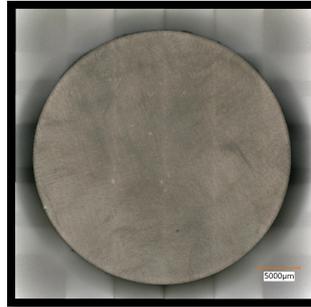
14-1-11 Zintl



1-2-2 Zintl



9-4-9 Zintl



La<sub>3-x</sub>Te<sub>4</sub>



La<sub>3-x</sub>Te<sub>4</sub>  
/composite



- Large pucks enable rapid TE leg production to feed the device fabrication effort.
- Based on current TE leg dimensions (8-couple multicouple configuration), puck size sufficient to support production of legs and devices for full scale generator.

# Elements Highlight

- Completed Scale Up Fabrication of Metallized Pucks of TE Materials for 14-1-11 Zintl and SKDs
- Currently Developing Dicing Procedures

Metallized 14-1-11 32mm diameter puck



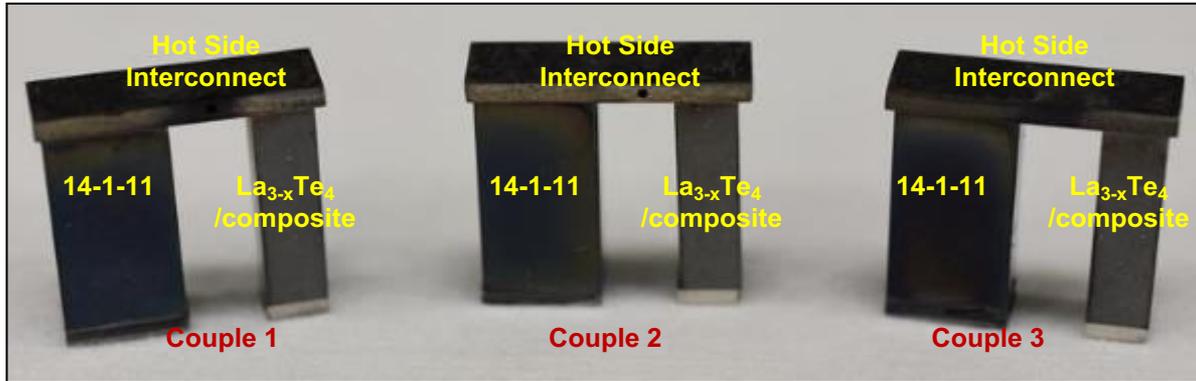
Metallized p-SKD 32mm diameter puck



Diced puck – wax side



# Devices Highlight

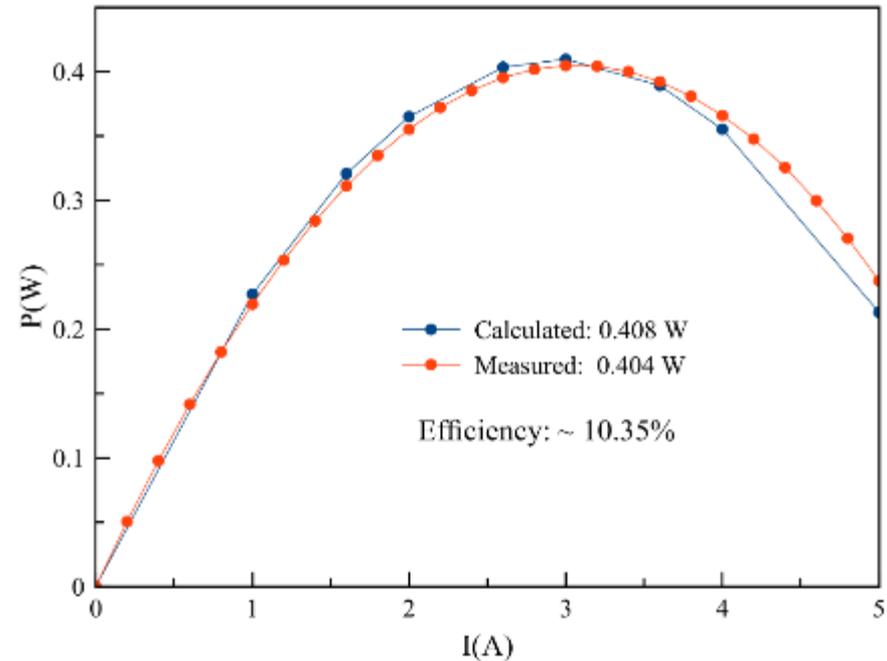
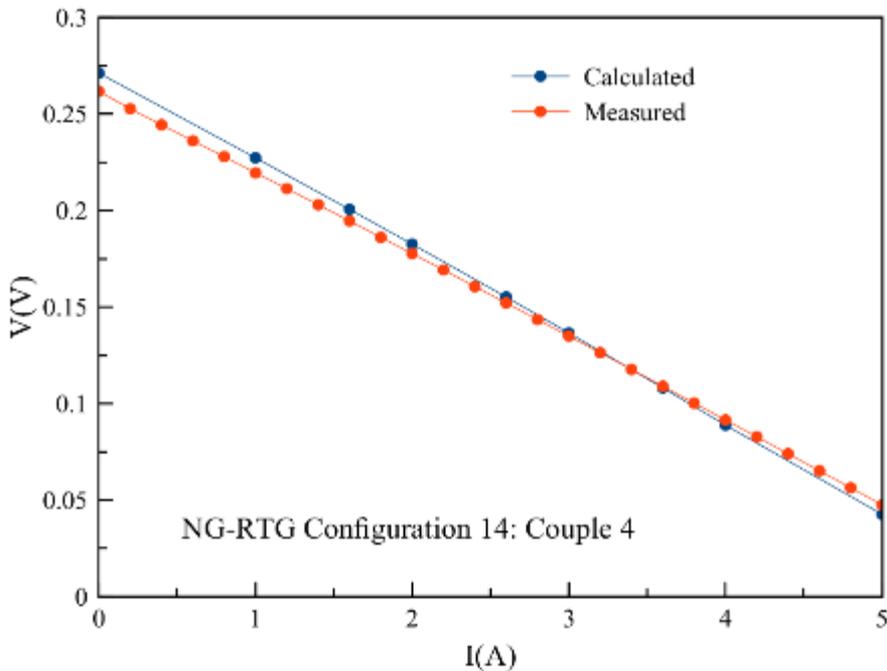


	Couple Resistance (mOhm)
Couple 1	15.50
Couple 2	15.61
Couple 3	15.45

- Consistent room temperature end-to-end resistance in all three couples.
- Couples are tested at 1000°C, 900°C, and 800°C hot junction temperatures in order to evaluate long term stability and kinetics of degradation rates.

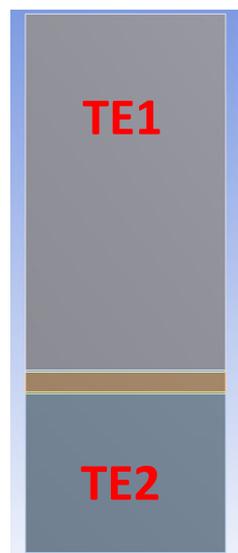
# Devices Highlight

## BOL Data Device Level Verification – Long Term Testing Currently In Progress

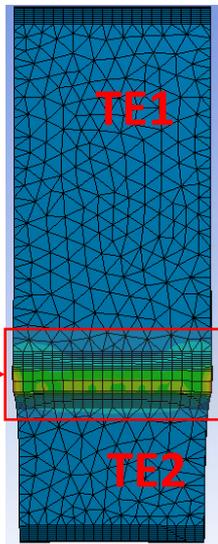
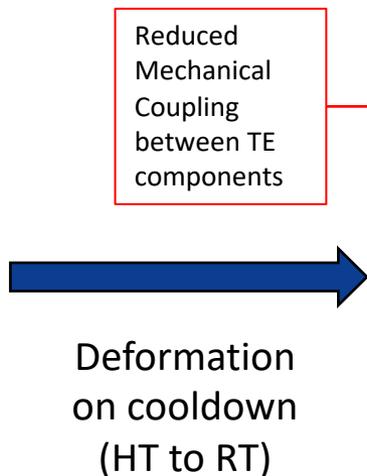


- $T_{hj} \sim 1000 \text{ }^\circ\text{C}$ ,  $T_{cj} \sim 200 \text{ }^\circ\text{C}$
- Good agreement between experimental data and FEA calculations.
- $P_{max} \sim 0.410 \text{ Watts @ } I=3 \text{ A}$
- Efficiency  $e \sim 10.35\%$

# Technology Highlight: Development of Compliant Interfaces

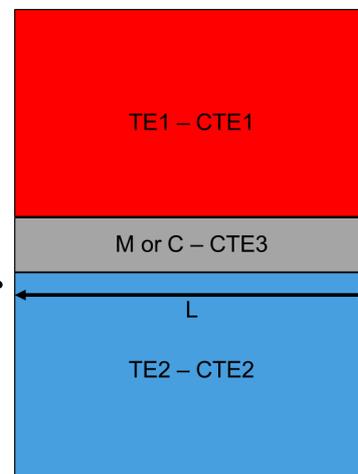


Compliant Structure is bonded between the high-temperature (HT) and low temperature (LT) TE sections



During Cooldown, because of CTE mismatch, the LT TE contracts more than the HT TE, which leads to high stress and subsequently crack formation. The compliant structure mechanically isolates the HT TE from the LT TE Components, hence reduces stress transfer and eliminates crack formation.

## Generic Physical Model



**TE:** Thermoelectric Element  
**CTE:** Coefficient of Thermal Expansion  
**M:** Metal  
**C:** Compliant

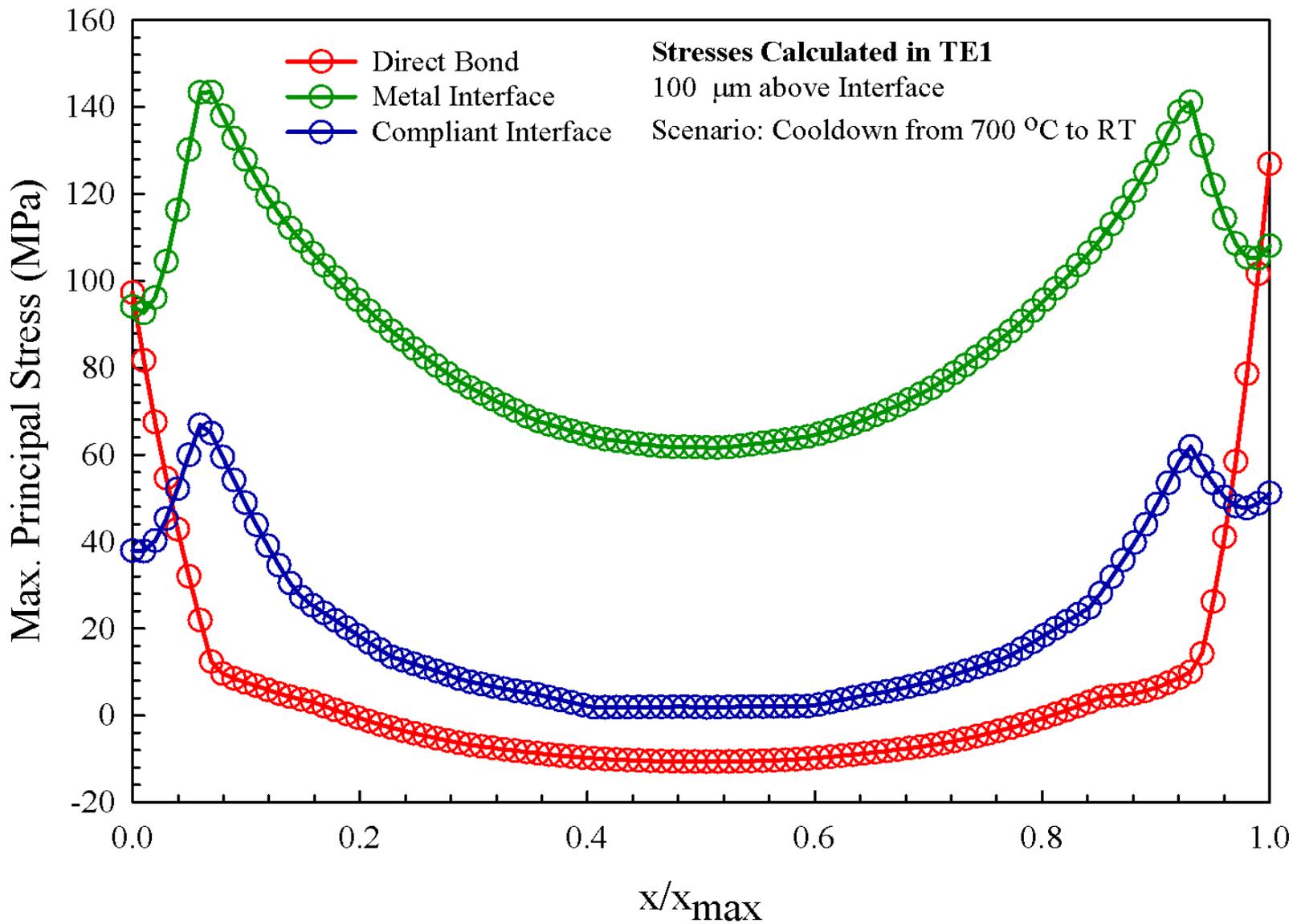
Stress in TEs Is Reduced When

- CTE1 ~ CTE2 ~ CTE3 (CTE Matching)

Or

- Presence of Low Modulus Intermediate Layer (Compliant Layer)

# Technology Highlight: Development of Compliant Interfaces



# Conclusions

- Set of thermoelectric materials have been selected for Next Gen RTG device technology development.
  - Scale-up synthesis has been demonstrated for all materials.
  - Considerable progress has been made measuring relevant material properties (TE Properties, Mechanical Properties, Bare Sublimation Rates).
  - Extended (1-2 years) thermoelectric property stability testing has been completed for several of these materials.
  - Targeting completion of all materials development and characterization work in FY19.
- Device-level technology development is in progress
  - Focus is on two segmented and one unsegmented couple configuration.
  - Developed Compliant Interfaces that Minimize Stress Due to CTE Mismatch.
  - Developed FEA models for Thermomechanical Analysis and Thermoelectric Analysis to help guide design trades.
  - First round of extended device performance testing is underway.
- Selected Next Gen RTG device configurations offer ample margin against initial performance target
  - Will help minimize initial technology development risks.

# Acknowledgements

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